


<b>Search Notes</b> 	<b>Application/Control No.</b> 10823330	<b>Applicant(s)/Patent Under Reexamination</b> OHIRA, TADASHI
	<b>Examiner</b> EUENG-NAN YEH	<b>Art Unit</b> 2624

### SEARCHED

Class	Subclass	Date	Examiner
382	239	2010.05.12	/ey/
341	51	2010.05.12	/ey/
358	426.02-426.11	2010.05.12	/ey/

### SEARCH NOTES

Search Notes	Date	Examiner
(382/239) text search - see search outputs	2008/04/23	/ey/
EAST text search - see search outputs	2008/04/23	/ey/
Google search - see search outputs	2008/04/23	/ey/
IEEE search - see search outputs	2008/04/23	/ey/
PALM inventor search - see search outputs	2008/04/23	/ey/
PTO PLUS search - see search outputs	2008/04/23	/ey/
EAST text search - see search history list	2009.05.13	/ey/
EAST text search - see search history list printout	2009/11/16	/ey/
EAST update search - see search history list	2010.05.12	/ey/

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
	PGPUB text search - May 12, 2010, see interference search printout	2010.05.12	/ey/

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Examiner, Art Unit 2624